

## 超小型，低输入电压低，低 $R_{\text{导通}}$ 负载开关

查询样品: [TPS22924D](#)

### 特性

- 集成单负载开关
- 输入电压: **0.75V 至 3.6V**
- 超低导通电阻
  - $V_{\text{输入}} = 3.6\text{V}$  时,  $r_{\text{导通}} = 18.3\text{m}\Omega$
  - $V_{\text{输入}} = 2.5\text{V}$  时,  $r_{\text{导通}} = 18.5\text{m}\Omega$
  - $V_{\text{输入}} = 1.8\text{V}$  时,  $r_{\text{导通}} = 19.6\text{m}\Omega$
  - $V_{\text{输入}} = 1.2\text{V}$  时,  $r_{\text{导通}} = 19.4\text{m}\Omega$
  - $V_{\text{输入}} = 1.0\text{V}$  时,  $r_{\text{导通}} = 20.3\text{m}\Omega$
  - $V_{\text{输入}} = 0.75\text{V}$  时,  $r_{\text{导通}} = 22.7\text{m}\Omega$
- **1.4mm x 0.9mm**, 焊球间距 **0.5mm**, 超小型芯片比例 (CSP)-6 封装
- **2A** 最大持续开关电流
- 低关断电流
- 低阈值控制输入
- 受控转换率以避免涌入电流
- 快速输出放电晶体管
- 静电放电 (ESD) 性能测试符合 **JESD 22** 标准
  - **5000V** 人体模型 (A114-B, II 类)
  - **1000V** 充电器件模型 (C101)

### 应用范围

- 电池供电类设备
- 便携式工业设备
- 便携式医疗设备
- 便携式媒体播放器
- 销售点终端
- 全球卫星定位(GPS)设备
- 数码摄像机
- 笔记本/平板电脑/电子阅读器
- 智能电话

### 说明

TPS22924D 是一款小型，超低  $R_{\text{导通}}$  负载开关，此开关具有可控接通功能。此器件包含一个 N 通道 MOSFET，此 MOSFET 可运行在 0.75V 至 3.6V 的输入电压范围内。一个集成的电荷泵把 NMOS 开关偏置，以实现一个最小的开关导通电阻。此开关可由一个打开/关闭输入 (ON) 控制，此输入可与低压控制信号直接对接。

添加了一个 1250 $\Omega$  片载负载电阻器，以便在开关被关闭时实现输出快速放电。此器件的上升时间受到内部控制以避免涌入电流。电压为 3.6V 时，TPS22924D 特有一个 6200 $\mu\text{s}$  的上升时间。

TPS22924D 采用超小型、节省空间的 6 引脚 CSP 封装，并可在 -40 $^{\circ}\text{C}$  至 85 $^{\circ}\text{C}$  的自然通风温度范围内运行。

图 1. 典型应用

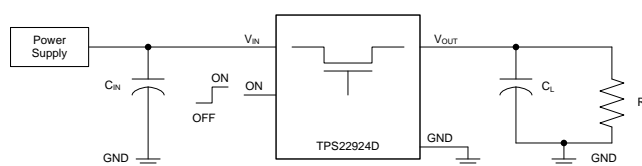


表 1. 特性列表

	3.6V 时的 $r_{\text{导通}}$ (典型值)	3.6V 时, 转换率 (典型值)	快速输出放电 <sup>(1)</sup>	最大输出电压	使能
TPS22924D	18.3m $\Omega$	6200 $\mu\text{s}$	支持	2A	高电平有效

(1) 此特性可通过一个 1250 $\Omega$  电阻器将开关的输出放电至接地水平，从而防止此输出悬空。请参见应用信息中的输出下拉部分。



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

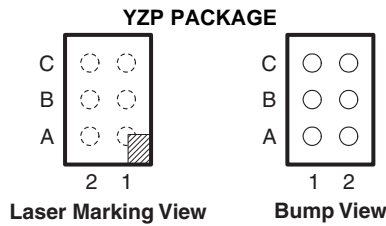


This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

**ORDERING INFORMATION**

For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI web site at [www.ti.com](http://www.ti.com)



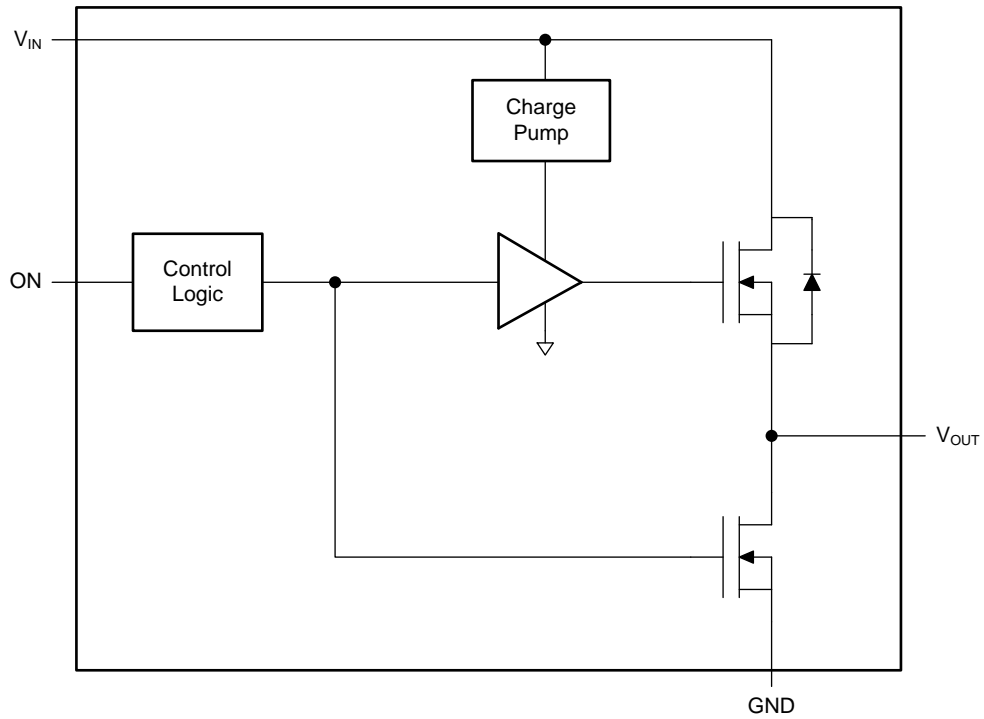
**TERMINALS ASSIGNMENTS (YZP PACKAGE)**

C	GND	ON
B	VOUT	VIN
A	VOUT	VIN
	1	2

**TERMINAL FUNCTIONS**

NO.	NAME	DESCRIPTION
C1	GND	Ground
C2	ON	Switch control input, active high. Do not leave floating
A1, B1	VOUT	Switch output
A2, B2	VIN	Switch input. Place a decoupling capacitor from VIN to GND. See Application Information section for details about input capacitors.

**BLOCK DIAGRAM**



**FUNCTION TABLE**

ON (Control Signal)	VIN to VOUT	VOUT to GND <sup>(1)</sup>
L	OFF	ON
H	ON	OFF

(1) See application section *Output Pulldown*.

**ABSOLUTE MAXIMUM RATINGS<sup>(1)</sup>**

		MIN	MAX	UNIT
V <sub>IN</sub>	Input voltage range	-0.3	4	V
V <sub>OUT</sub>	Output voltage range		V <sub>IN</sub> + 0.3	V
V <sub>ON</sub>	ON pin voltage range	-0.3	4	V
I <sub>MAX</sub>	Maximum continuous switch current, T <sub>A</sub> = -40°C to 85°C		2	A
I <sub>PLS</sub>	Maximum pulsed switch current, 100-μs pulse, 2% duty cycle, T <sub>A</sub> = -40°C to 85°C		4	A
T <sub>A</sub>	Operating free-air temperature range	-40	85	°C
T <sub>stg</sub>	Storage temperature range	-65	150	°C
ESD	Electrostatic discharge protection	Human-Body Model (HBM)		V
		Charged-Device Model (CDM)		

- (1) Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

**DISSIPATION RATINGS**

BOARD	PACKAGE	R <sub>θJC</sub>	R <sub>θJA</sub>	DERATING FACTOR ABOVE T <sub>A</sub> = 25°C	T <sub>A</sub> < 25°C	T <sub>A</sub> = 70°C	T <sub>A</sub> = 85°C
High-K <sup>(1)</sup>	YZP	17.6°C/W	123.36°C/W	- 8.1063 mW/°C	810.63 mW	445.84 mW	324.25 mW

- (1) The JEDEC high-K (2s2p) board used to derive this data was a 3- × 3-inch, multilayer board with 1-ounce internal power and ground planes and 2-ounce copper traces on top and bottom of the board.

**RECOMMENDED OPERATING CONDITIONS**

		MIN	MAX	UNIT
V <sub>IN</sub>	Input voltage	0.75	3.6	V
V <sub>OUT</sub>	Output voltage		V <sub>IN</sub>	V
V <sub>IH</sub>	High-level input voltage, ON	V <sub>IN</sub> = 2.5 V to 3.6 V		V
		V <sub>IN</sub> = 0.75 V to 2.5 V		
V <sub>IL</sub>	Low-level input voltage, ON	V <sub>IN</sub> = 2.5 V to 3.6 V		V
		V <sub>IN</sub> = 0.75 V to 2.49 V		
C <sub>IN</sub>	Input capacitance	1 <sup>(1)</sup>		μF

- (1) See the *Input Capacitor* section in Application Information.

## ELECTRICAL CHARACTERISTICS

 $V_{IN} = 0.75\text{ V to }3.6\text{ V}$  (unless otherwise noted)

PARAMETER		TEST CONDITIONS		$T_A$	MIN	TYP <sup>(1)</sup>	MAX	UNIT			
$I_{Q, V_{IN}}$	Quiescent current	$V_{OUT} = \text{open}, V_{IN} = V_{ON}$	Full	Full				$\mu\text{A}$			
									$V_{IN} = 3.6\text{ V}$	75	160
									$V_{IN} = 2.5\text{ V}$	42	100
									$V_{IN} = 1.8\text{ V}$	50	350
									$V_{IN} = 1.2\text{ V}$	95	200
									$V_{IN} = 1.0\text{ V}$	65	120
$I_{SD, V_{IN}}$	Shutdown current	$V_{ON} = \text{GND}, V_{OUT} = 0\text{V}$	Full	Full			4.0	$\mu\text{A}$			
$R_{ON}$	ON-state resistance	$I_{OUT} = -200\text{ mA}$	Full	Full	25°C			$\text{m}\Omega$			
									$V_{IN} = 3.6\text{ V}$	18.3	22.8
									$V_{IN} = 2.5\text{ V}$	18.5	23.0
									$V_{IN} = 1.8\text{ V}$	19.6	24.1
									$V_{IN} = 1.2\text{ V}$	19.4	23.9
									$V_{IN} = 1.0\text{ V}$	20.3	24.8
									$V_{IN} = 0.75\text{ V}$	22.7	27.2
									$R_{PD}$	Output pulldown resistance <sup>(2)</sup>	$V_{IN} = 3.3\text{ V}, V_{ON} = 0, I_{OUT} = 1\text{ mA}$
$I_{ON}$	ON-pin input leakage current	$V_{ON} = 0.9\text{ V to }3.6\text{ V or GND}$	Full	Full			0.1	$\mu\text{A}$			

(1) Typical values are at  $V_{IN} = 3.3\text{ V}$  and  $T_A = 25^\circ\text{C}$ .

(2) See [Output Pulldown](#) in *Application Information*.

## SWITCHING CHARACTERISTICS

 $V_{IN} = 3.6\text{ V}, T_A = 25^\circ\text{C}$  (unless otherwise noted)

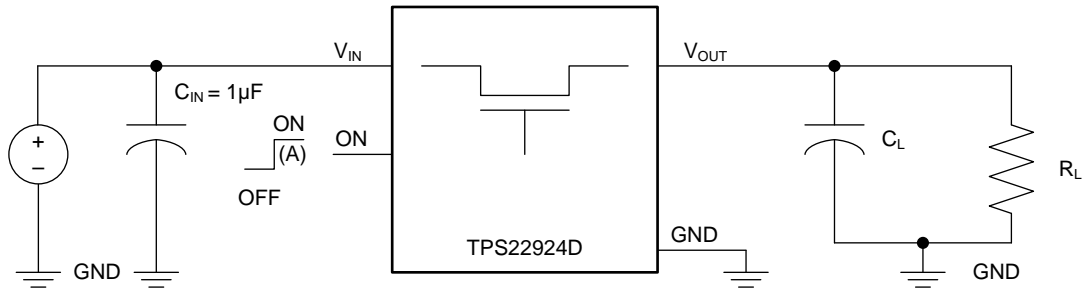
PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
$t_{ON}$	Turn-ON time	$R_L = 10\ \Omega, C_L = 0.1\ \mu\text{F}, V_{IN} = 3.6\text{V}$			7400		$\mu\text{s}$
$t_{OFF}$	Turn-OFF time	$R_L = 10\ \Omega, C_L = 0.1\ \mu\text{F}, V_{IN} = 3.6\text{V}$			2.5		$\mu\text{s}$
$t_r$	$V_{OUT}$ rise time	$R_L = 10\ \Omega, C_L = 0.1\ \mu\text{F}, V_{IN} = 3.6\text{V}$			6200		$\mu\text{s}$
$t_f$	$V_{OUT}$ fall time	$R_L = 10\ \Omega, C_L = 0.1\ \mu\text{F}, V_{IN} = 3.6\text{V}$			2		$\mu\text{s}$

## SWITCHING CHARACTERISTICS

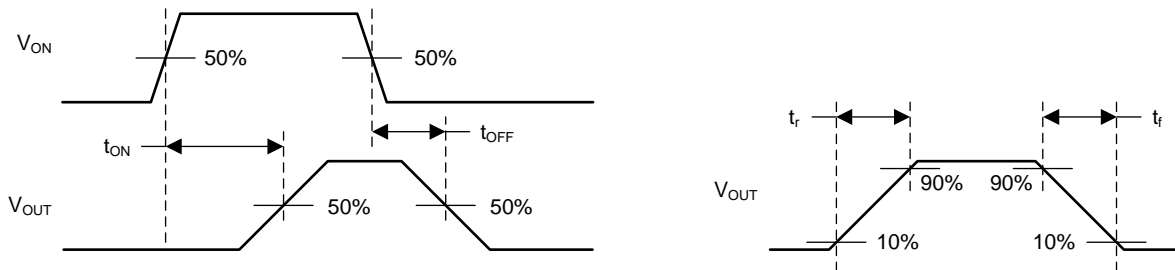
 $V_{IN} = 0.9\text{ V}, T_A = 25^\circ\text{C}$  (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
$t_{ON}$	Turn-ON time	$R_L = 10\ \Omega, C_L = 0.1\ \mu\text{F}, V_{IN} = 0.9\text{V}$			6300		$\mu\text{s}$
$t_{OFF}$	Turn-OFF time	$R_L = 10\ \Omega, C_L = 0.1\ \mu\text{F}, V_{IN} = 0.9\text{V}$			12		$\mu\text{s}$
$t_r$	$V_{OUT}$ rise time	$R_L = 10\ \Omega, C_L = 0.1\ \mu\text{F}, V_{IN} = 0.9\text{V}$			3200		$\mu\text{s}$
$t_f$	$V_{OUT}$ fall time	$R_L = 10\ \Omega, C_L = 0.1\ \mu\text{F}, V_{IN} = 0.9\text{V}$			3		$\mu\text{s}$

PARAMETRIC MEASUREMENT INFORMATION



TEST CIRCUIT



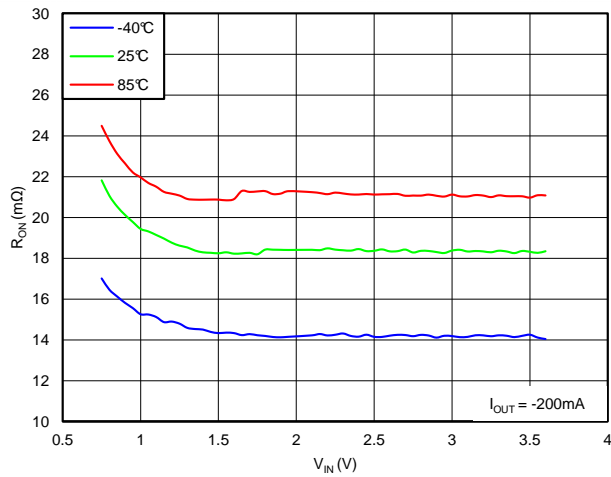
$t_{ON}/t_{OFF}$  WAVEFORMS

A. Rise and fall times of the control signal is 100ns

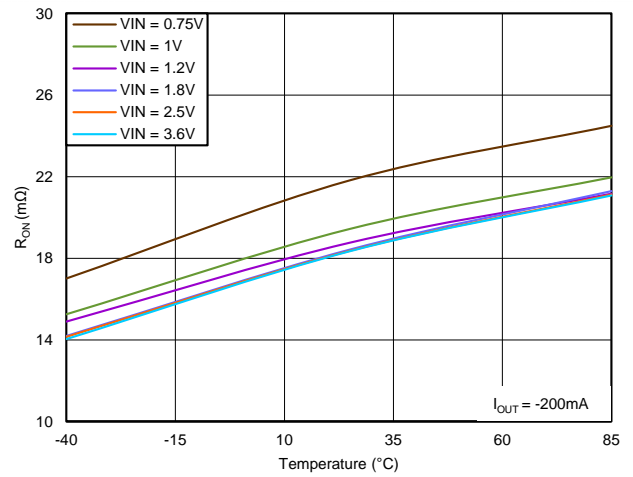
Figure 2. Test Circuit and  $t_{ON}/t_{OFF}$  Waveforms

TYPICAL CHARACTERISTICS

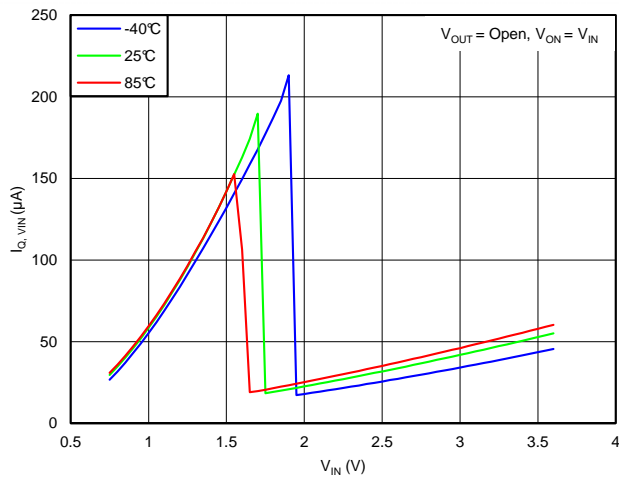
ON-STATE RESISTANCE  
vs  
INPUT VOLTAGE



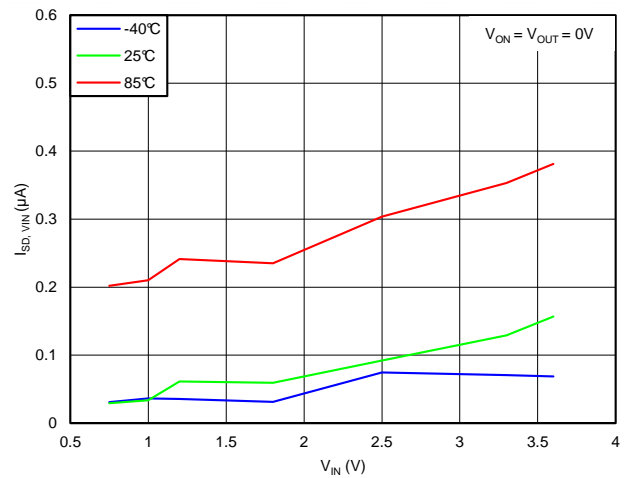
ON-STATE RESISTANCE  
vs  
TEMPERATURE



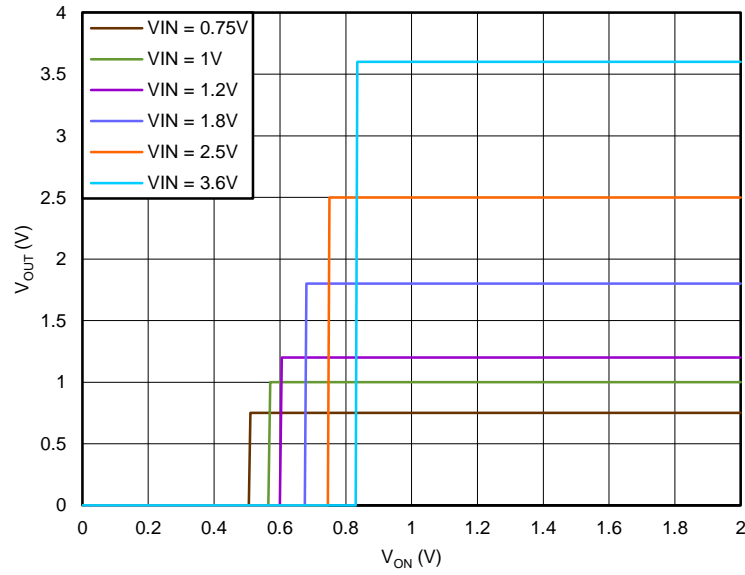
QUIESCENT CURRENT  
vs  
INPUT VOLTAGE



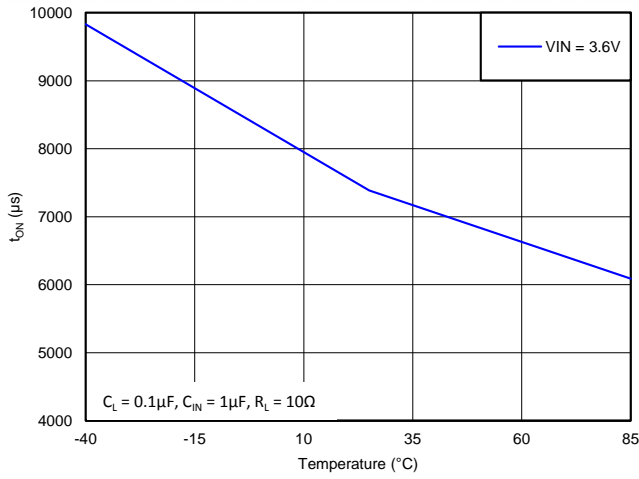
SHUTDOWN CURRENT  
vs  
INPUT VOLTAGE



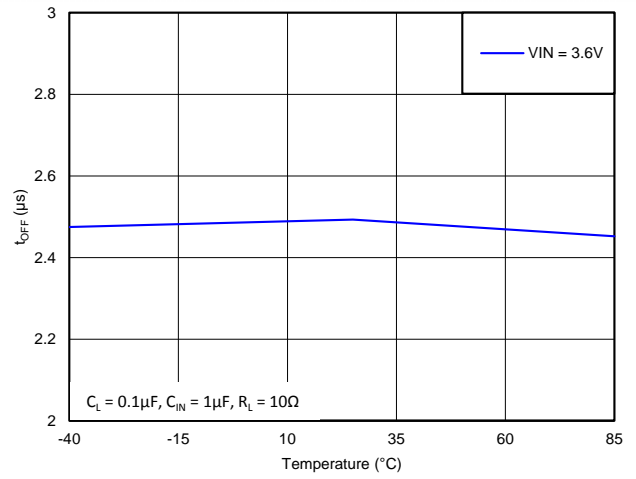
**TYPICAL CHARACTERISTICS (continued)**  
ON INPUT THRESHOLD



**TURN-ON TIME**  
VS  
**TEMPERATURE**  
 $V_{in} = 3.6\text{ V}, C_L = 0.1\ \mu\text{F}, R_L = 10\ \Omega$



**TURN-OFF TIME**  
VS  
**TEMPERATURE**  
 $V_{in} = 3.6\text{ V}, C_L = 0.1\ \mu\text{F}, R_L = 10\ \Omega$



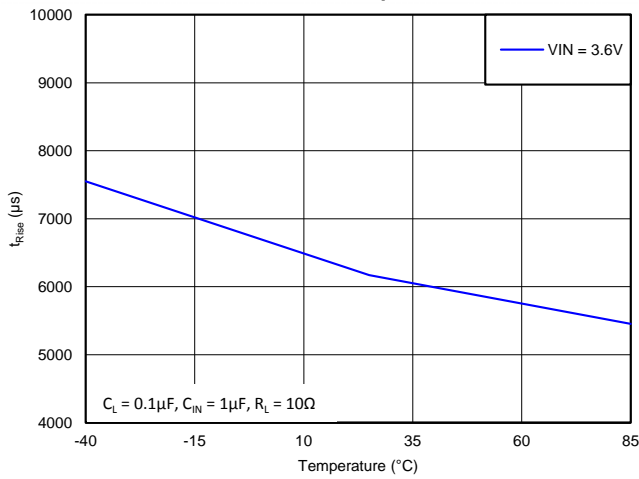


TYPICAL CHARACTERISTICS (continued)

RISE TIME

VS TEMPERATURE

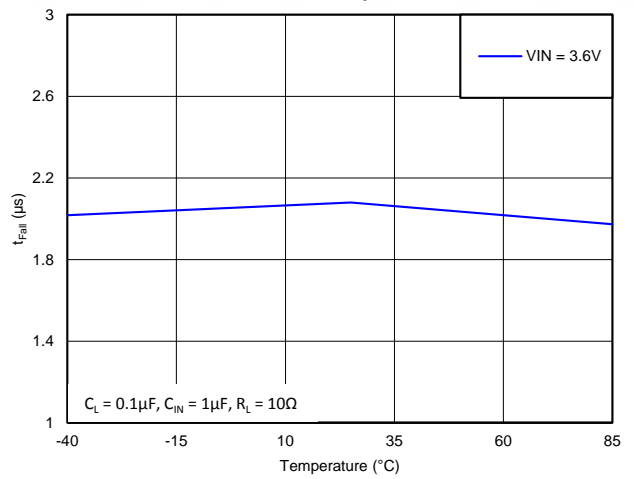
$V_{IN} = 3.6\text{ V}$ ,  $C_L = 0.1\ \mu\text{F}$ ,  $R_L = 10\ \Omega$



FALL TIME

VS TEMPERATURE

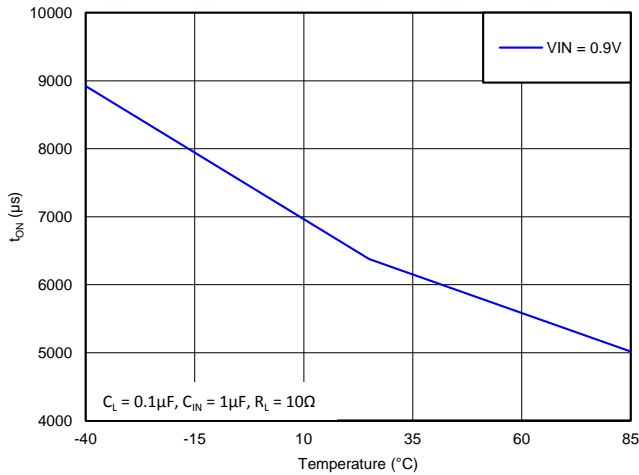
$V_{IN} = 3.6\text{ V}$ ,  $C_L = 0.1\ \mu\text{F}$ ,  $R_L = 10\ \Omega$



TURN-ON TIME

VS TEMPERATURE

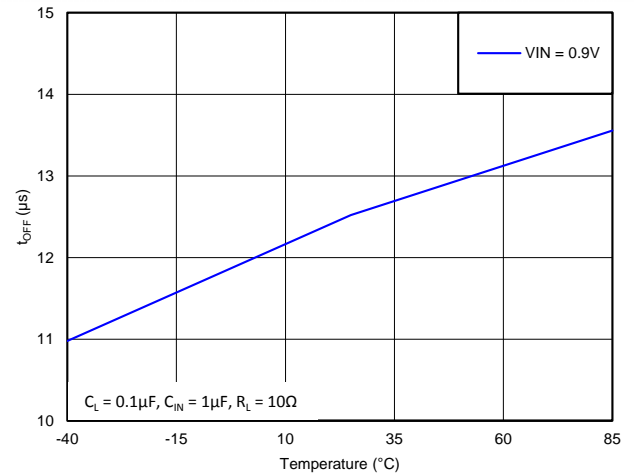
$V_{IN} = 0.9\text{ V}$ ,  $C_L = 0.1\ \mu\text{F}$ ,  $R_L = 10\ \Omega$



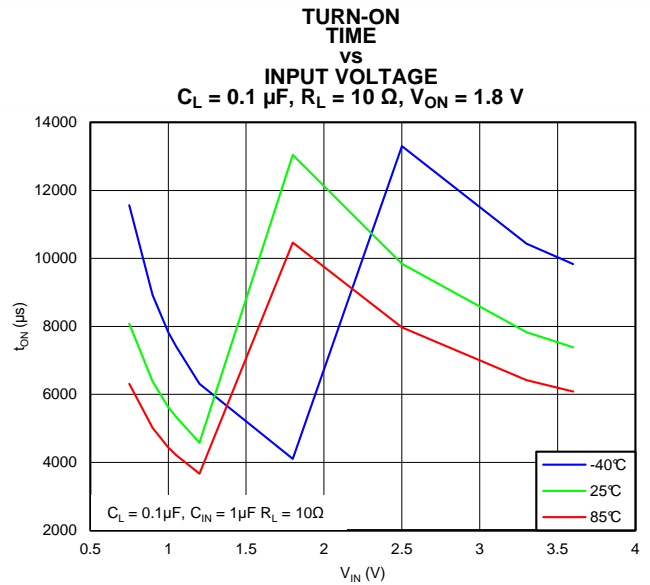
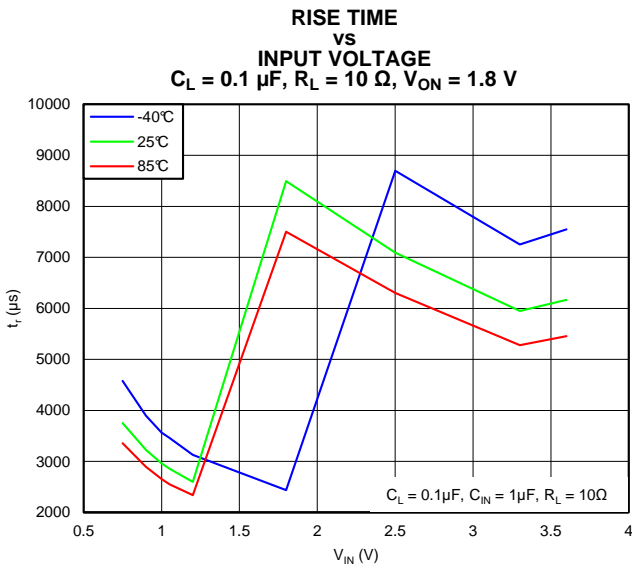
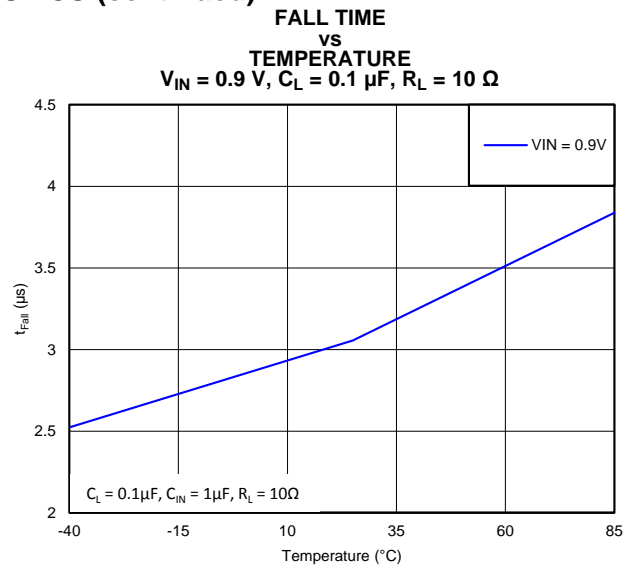
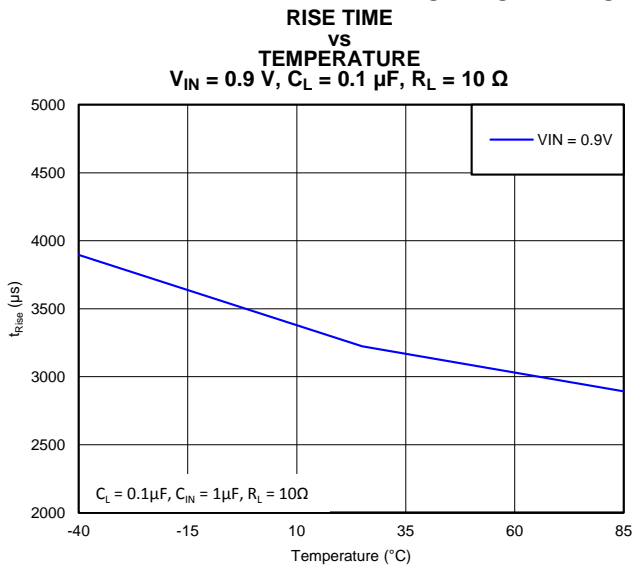
TURN-OFF TIME

VS TEMPERATURE

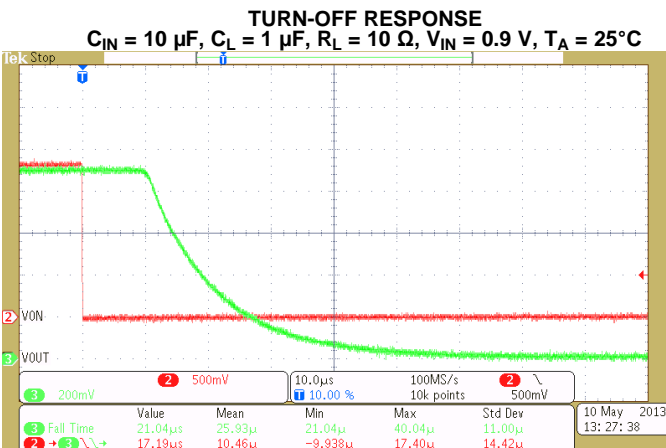
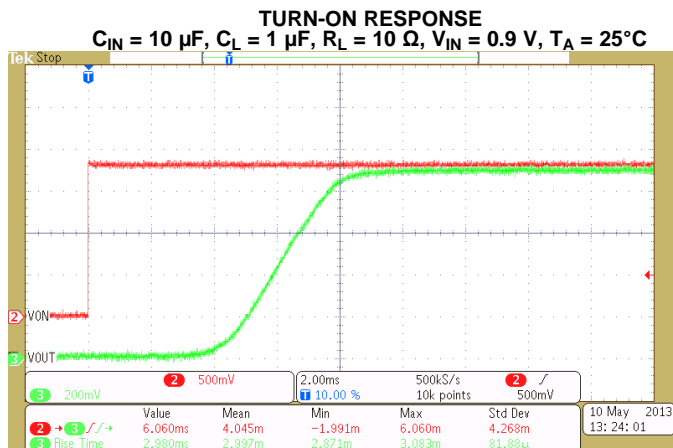
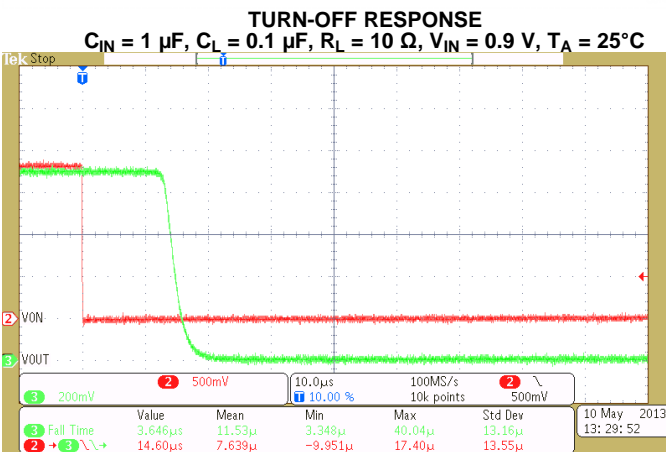
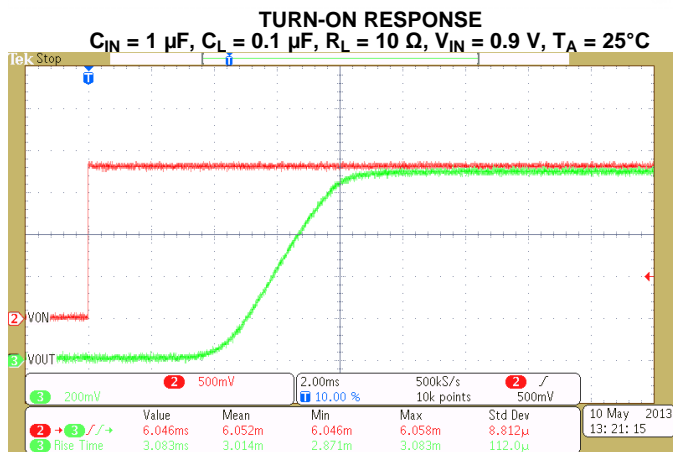
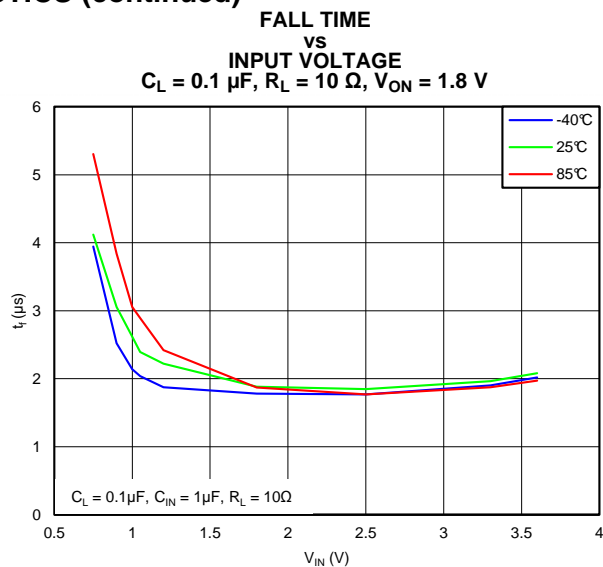
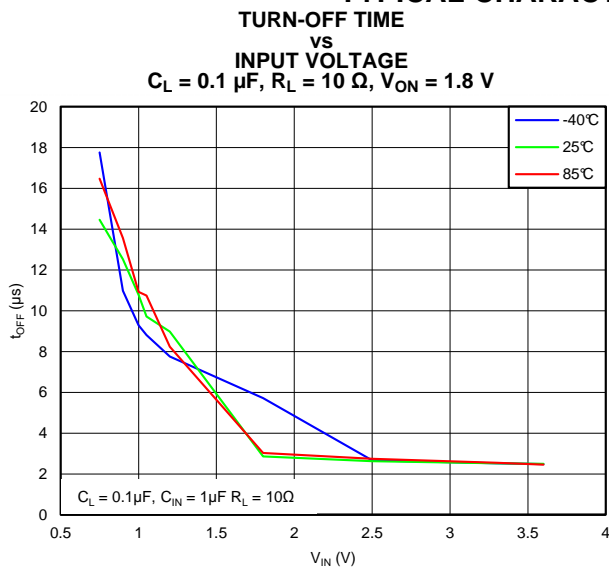
$V_{IN} = 0.9\text{ V}$ ,  $C_L = 0.1\ \mu\text{F}$ ,  $R_L = 10\ \Omega$



TYPICAL CHARACTERISTICS (continued)



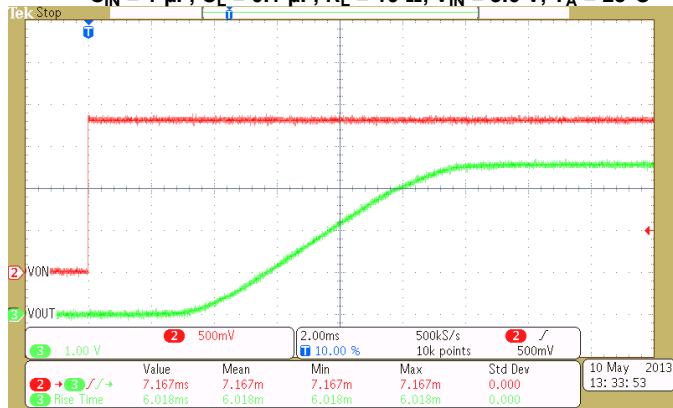
TYPICAL CHARACTERISTICS (continued)



**TYPICAL CHARACTERISTICS (continued)**

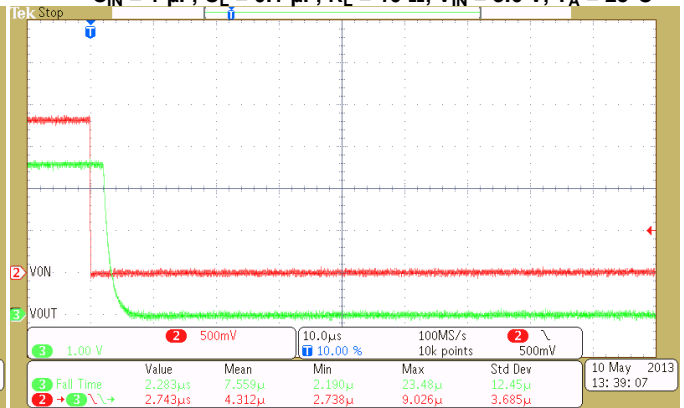
**TURN-ON RESPONSE**

$C_{IN} = 1 \mu F, C_L = 0.1 \mu F, R_L = 10 \Omega, V_{IN} = 3.6 V, T_A = 25^\circ C$



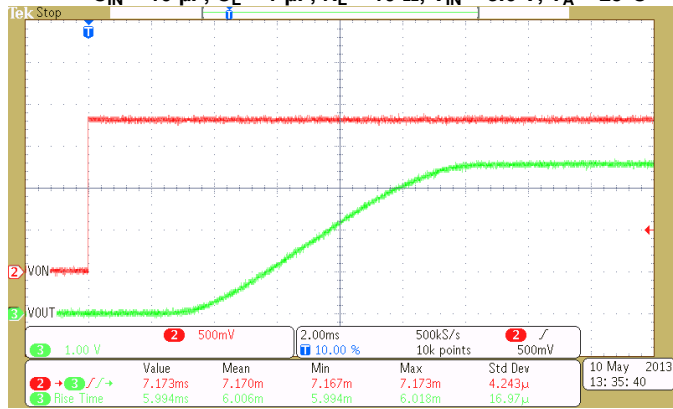
**TURN-OFF RESPONSE**

$C_{IN} = 1 \mu F, C_L = 0.1 \mu F, R_L = 10 \Omega, V_{IN} = 3.6 V, T_A = 25^\circ C$



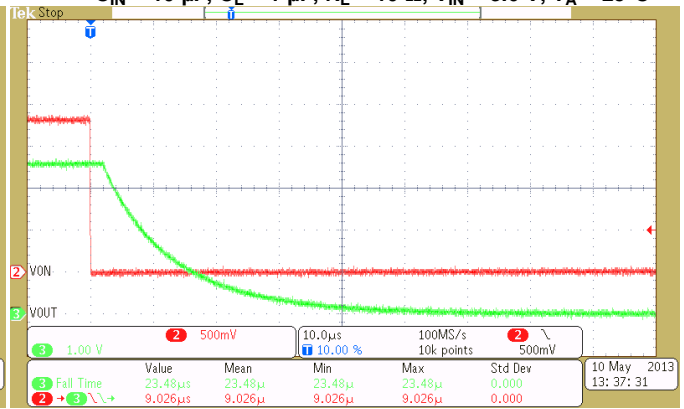
**TURN-ON RESPONSE**

$C_{IN} = 10 \mu F, C_L = 1 \mu F, R_L = 10 \Omega, V_{IN} = 3.6 V, T_A = 25^\circ C$



**TURN-OFF RESPONSE**

$C_{IN} = 10 \mu F, C_L = 1 \mu F, R_L = 10 \Omega, V_{IN} = 3.6 V, T_A = 25^\circ C$



## APPLICATION INFORMATION

### ON/OFF Control

The ON pin controls the state of the switch. Asserting ON high enables the switch. ON is active high and has a low threshold, making it capable of interfacing with low-voltage signals. The ON pin is compatible with standard GPIO logic threshold. It can be used with any microcontroller with 1.2-V, 1.8-V, 2.5-V or 3.3-V GPIOs.

### Input Capacitor

To limit the voltage drop on the input supply caused by transient inrush currents when the switch turns on into a discharged load capacitor or short-circuit, a capacitor needs to be placed between  $V_{IN}$  and GND. A 1- $\mu$ F ceramic capacitor,  $C_{IN}$ , placed close to the pins is usually sufficient. Higher values of  $C_{IN}$  can be used to further reduce the voltage drop.

### Output Capacitor

Due to the integrated body diode in the NMOS switch, a  $C_{IN}$  greater than  $C_L$  is highly recommended. A  $C_L$  greater than  $C_{IN}$  can cause  $V_{OUT}$  to exceed  $V_{IN}$  when the system supply is removed. This could result in current flow through the body diode from  $V_{OUT}$  to  $V_{IN}$ . A  $C_{IN}$  to  $C_L$  ratio of 10 to 1 is recommended for minimizing  $V_{IN}$  dip caused by inrush currents during startup.

### Output Pulldown

The output pulldown is active when the user is turning off the main pass FET. The pulldown discharges the output rail to approximately 10% of the rail, then the output pulldown is automatically disconnected to optimize the shutdown current.

### Board Layout

For best performance, all traces should be as short as possible. To be most effective, the input and output capacitors should be placed close to the device to minimize the effects that parasitic trace inductances may have on normal and short-circuit operation. Using wide traces for  $V_{IN}$ ,  $V_{OUT}$ , and GND helps minimize the parasitic electrical effects along with minimizing the case to ambient thermal impedance.

**PACKAGING INFORMATION**

Orderable part number	Status (1)	Material type (2)	Package   Pins	Package qty   Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
<a href="#">TPS22924DYZPR</a>	Active	Production	DSBGA (YZP)   6	3000   LARGE T&R	Yes	SNAGCU	Level-1-260C-UNLIM	-40 to 85	DL
TPS22924DYZPR.B	Active	Production	DSBGA (YZP)   6	3000   LARGE T&R	Yes	SNAGCU	Level-1-260C-UNLIM	-40 to 85	DL
<a href="#">TPS22924DYZPT</a>	Active	Production	DSBGA (YZP)   6	250   SMALL T&R	Yes	SNAGCU	Level-1-260C-UNLIM	-40 to 85	DL
TPS22924DYZPT.B	Active	Production	DSBGA (YZP)   6	250   SMALL T&R	Yes	SNAGCU	Level-1-260C-UNLIM	-40 to 85	DL

<sup>(1)</sup> **Status:** For more details on status, see our [product life cycle](#).

<sup>(2)</sup> **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

<sup>(4)</sup> **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

<sup>(6)</sup> **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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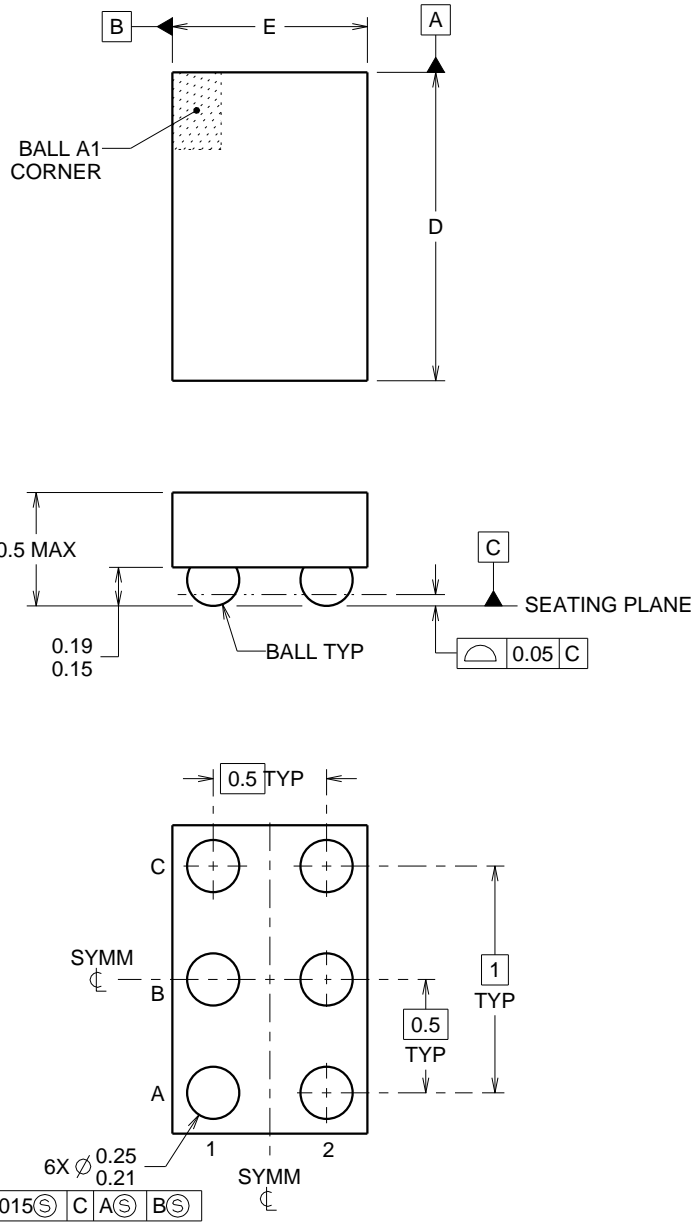
YZP0006



# PACKAGE OUTLINE

## DSBGA - 0.5 mm max height

DIE SIZE BALL GRID ARRAY



4219524/A 06/2014

NOTES:

NanoFree Is a trademark of Texas Instruments.

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. NanoFree™ package configuration.

# EXAMPLE BOARD LAYOUT

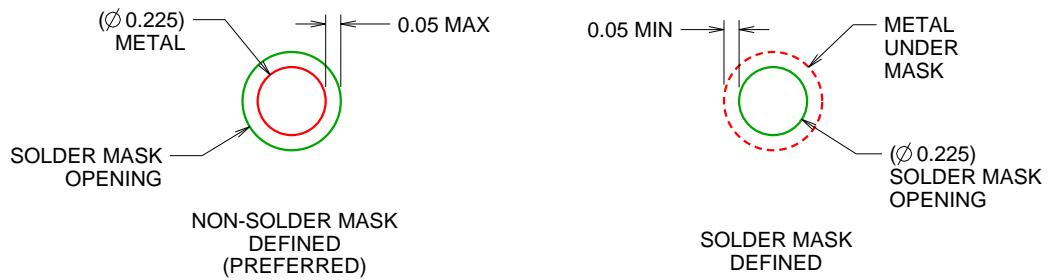
YZP0006

DSBGA - 0.5 mm max height

DIE SIZE BALL GRID ARRAY



LAND PATTERN EXAMPLE  
SCALE:40X



SOLDER MASK DETAILS  
NOT TO SCALE

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NOTES: (continued)

- Final dimensions may vary due to manufacturing tolerance considerations and also routing constraints. For more information, see Texas Instruments literature number SBVA017 ([www.ti.com/lit/sbva017](http://www.ti.com/lit/sbva017)).

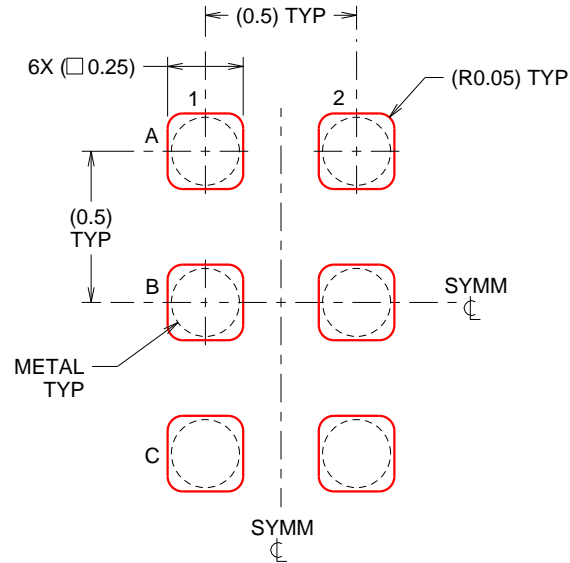


# EXAMPLE STENCIL DESIGN

YZP0006

DSBGA - 0.5 mm max height

DIE SIZE BALL GRID ARRAY



SOLDER PASTE EXAMPLE  
BASED ON 0.1 mm THICK STENCIL  
SCALE:40X

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NOTES: (continued)

5. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release.

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